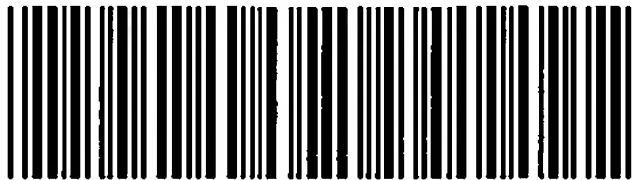


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/623,199	GROS ET AL.	
	Examiner	Art Unit	
	Gopal C. Ray	2111	

SEARCHED			
Class	Subclass	Date	Examiner
710	305,105,1 5,306	11/30/2005	GCR
709	224,217	11/30/2005	GCR
709	249	11/30/2005	GCR
370	245,252	11/30/2005	GCR
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702	122,190	11/30/2005	GCR
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370	401,402	11/30/2005	GCR
370	465	11/30/2005	GCR

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PGPUB text search - see interference search printout		11/30/2005	GCR

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	11/30/2005	GCR
EAST: USPT (see search history printouts)	11/30/2005	GCR
NPL: IEEE Xplore (see search history printouts)	11/30/2005	GCR